

**Notice of References Cited**

Application/Control No.

10/526,019

Applicant(s)/Patent Under  
Reexamination  
KANNAN ET AL.

Examiner

Jeffrie R. Lund

Art Unit

1792

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,747,367	05-1988	Posa, John G.	118/715
*	B	US-5,381,756	01-1995	Kondo et al.	117/104
*	C	US-5,458,085	10-1995	Kondo et al.	148/33.6
*	D	US-5,496,408	03-1996	Motoda et al.	118/715
*	E	US-5,702,532	12-1997	Wen et al.	118/730
*	F	US-5,725,913	03-1998	Wong et al.	427/530
*	G	US-5,785,796	07-1998	Lee, Hideki	156/345.24
*	H	US-6,122,429	09-2000	Wessels et al.	385/130
*	I	US-6,217,659 B1	04-2001	Botelho et al.	118/715
*	J	US-6,428,850 B1	08-2002	Shinriki et al.	427/255.32
*	K	US-6,503,330 B1	01-2003	Sneh et al.	118/715
*	L	US-6,743,739 B2	06-2004	Shimamoto et al.	438/780
*	M	US-2002/0073924 A1	06-2002	Chiang et al.	118/723.00R

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

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<b>Notice of References Cited</b>	Application/Control No. 10/526,019	Applicant(s)/Patent Under Reexamination KANNAN ET AL.	
	Examiner Jeffrie R. Lund	Art Unit 1792	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0072875 A1	04-2003	Sandhu, Gurtej S.	427/248.1
*	B	US-2004/0083962 A1	05-2004	Bang et al.	118/715
*	C	US-2004/0226507 A1	11-2004	Carpenter et al.	118/715
*	D	US-2005/0016956 A1	01-2005	Liu et al.	216/067
*	E	US-2006/0154383 A1	07-2006	Kannan et al.	438/005
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
	O					
	P					
	Q					
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	T					

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